RENESAS 8-output 1.5V PCIe Gen1-2-3 Clock Generator w/Zo=100ohms

9FGU0841

DATASHEET

General Description

The 9FGU0841 is a member of IDT's 1.5V Ultra-Low-Power PCIe clock family with integrated output terminations providing Zo=100 Ω . The device has 8 output enables for clock management, 2 different spread spectrum levels in addition to spread off and 2 selectable SMBus addresses.

Recommended Application

1.5V PCIe Gen1-2-3 Clock Generator

Output Features

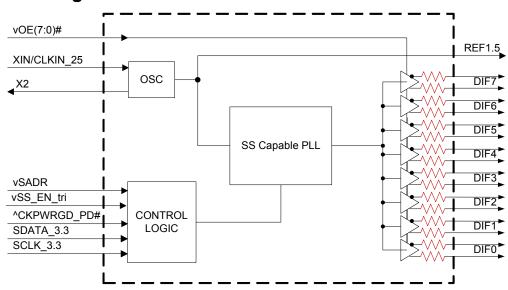
- 8 100MHz Low-Power (LP) HCSL DIF pairs w/Zo=100ohms
- 1 1.5V LVCMOS REF output w/Wake-On-LAN (WOL) support

Key Specification

- DIF cycle-to-cycle jitter <50ps
- DIF output-to-output skew < 60ps
- DIF phase jitter is PCIe Gen1-2-3 compliant
- REF phase jitter is < 3.0ps RMS

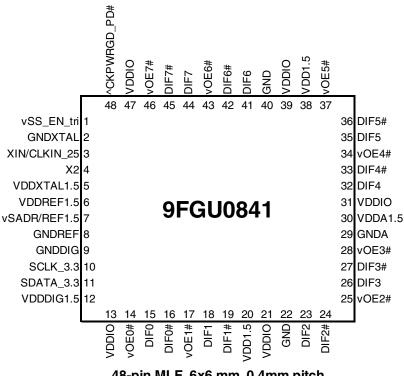
Features/Benefits

- Direct connection to 100ohm transmission lines; saves 32 resistors compared to standard PCIe devices
- 50mW typical power consumption; reduced thermal concerns
- Outputs can optionally be supplied from any voltage between 1.05 and 1.5V; maximum power savings
- OE# pins; support DIF power management
- Programmable Slew rate for each output; allows tuning for various line length
- Programmable output amplitude; allows tuning for various application environments
- DIF outputs blocked until PLL is locked; clean system start-up
- Selectable 0%, -0.25% or -0.5% spread on DIF outputs; reduces EM
- External 25MHz crystal; supports tight ppm with 0 ppm synthesis error
- Configuration can be accomplished with strapping pins; SMBus interface not required for device control
- Selectable SMBus addresses; multiple devices can easily share an SMBus segment
- 3.3V tolerant SMBus interface works with legacy controllers
- Space saving 48-pin 6x6 mm VFQFPN; minimal board space



Functional Block Diagram

Pin Configuration



48-pin MLF, 6x6 mm, 0.4mm pitch

- vv prefix indicates internal 60KOhm pull down resistor
- v prefix indicates internal 120KOhm pull down resistor
- ^ prefix indicates internal 120KOhm pull up resistor

Power Management Table

CKPWRGD PD#	SMBus		DIFx		REF
	OE bit	OEx#	True O/P	Comp. O/P	
0	Х	Х	Low	Low	Hi-Z ¹
1	1	0	Running	Running	Running
1	0	1	Low	Low	Low

1. REF is Hi-Z until the 1st assertion of CKPWRGD_PD# high. After this, when CKPWRGD_PD# is low, REF is Low.

SMBus Address Selection Table

	SADR	Address	+ Read/Write Bit
State of SADR on first application	0	1101000	Х
of CKPWRGD_PD#	1	1101010	Х

Power Connections

Pin Number		Description	
VDD	VDDIO	GND	Description
5		2	XTAL OSC
6		8	REF Power
12		9	Digital (dirty) Power
20,38	13,21,31,39, 47	22,29,40	DIF outputs
30		29	PLL Analog

Pin Descriptions

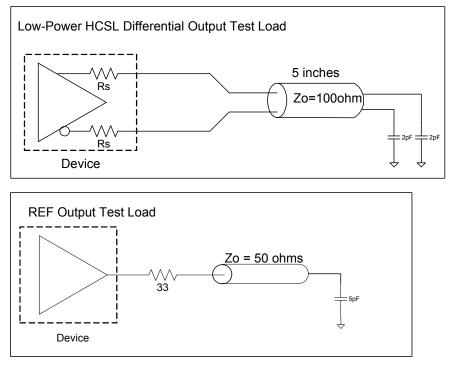
PIN #	PIN NAME	TYPE	DESCRIPTION
1	vSS_EN_tri	LATCHED	Latched select input to select spread spectrum amount at initial power up :
I	V35_EN_III	IN	1 = -0.5% spread, M = -0.25%, 0 = Spread Off
2	GNDXTAL	GND	GND for XTAL
3	XIN/CLKIN_25	IN	Crystal input or Reference Clock input. Nominally 25MHz.
4	X2	OUT	Crystal output.
5	VDDXTAL1.5	PWR	Power supply for XTAL, nominal 1.5V
6	VDDREF1.5	PWR	VDD for REF output. nominal 1.5V.
7	vSADR/REF1.5	LATCHED I/O	Latch to select SMBus Address/1.5V LVCMOS copy of X1/REFIN pin
8	GNDREF	GND	Ground pin for the REF outputs.
9	GNDDIG	GND	Ground pin for digital circuitry
10	SCLK_3.3	IN	Clock pin of SMBus circuitry, 3.3V tolerant.
11	SDATA_3.3	I/O	Data pin for SMBus circuitry, 3.3V tolerant.
12	VDDDIG1.5	PWR	1.5V digital power (dirty power)
13	VDDIO	PWR	Power supply for differential outputs
14	vOE0#	IN	Active low input for enabling DIF pair 0. This pin has an internal pull-down. 1 =disable outputs, 0 = enable outputs
15	DIF0	OUT	Differential true clock output
16	DIF0#	OUT	Differential Complementary clock output
17	vOE1#	IN	Active low input for enabling DIF pair 1. This pin has an internal pull-down. 1 =disable outputs, 0 = enable outputs
18	DIF1	OUT	Differential true clock output
19	DIF1#	OUT	Differential Complementary clock output
20	VDD1.5	PWR	Power supply, nominally 1.5V
21	VDDIO	PWR	Power supply for differential outputs
22	GND	GND	Ground pin.
23	DIF2	OUT	Differential true clock output
24	DIF2#	OUT	Differential Complementary clock output
25	vOE2#	IN	Active low input for enabling DIF pair 2. This pin has an internal pull-down. 1 =disable outputs, 0 = enable outputs
26	DIF3	OUT	Differential true clock output
27	DIF3#	OUT	Differential Complementary clock output
28	vOE3#	IN	Active low input for enabling DIF pair 3. This pin has an internal pull-down. 1 =disable outputs, 0 = enable outputs
29	GNDA	GND	Ground pin for the PLL core.
30	VDDA1.5	PWR	1.5V power for the PLL core.
31	VDDIO	PWR	Power supply for differential outputs
32	DIF4	OUT	Differential true clock output
33	DIF4#	OUT	Differential Complementary clock output
34	vOE4#	IN	Active low input for enabling DIF pair 4. This pin has an internal pull-down. 1 =disable outputs, 0 = enable outputs
35	DIF5	OUT	Differential true clock output
36	DIF5#	OUT	Differential Complementary clock output
37	vOE5#	IN	Active low input for enabling DIF pair 5. This pin has an internal pull-down. 1 =disable outputs, 0 = enable outputs
38	VDD1.5	PWR	Power supply, nominally 1.5V
39	VDDIO	PWR	Power supply for differential outputs

Pin Description	ns (cont.)
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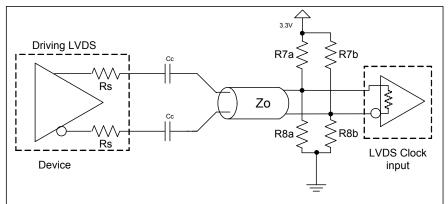
PIN #	PIN NAME	TYPE	DESCRIPTION
40	GND	GND	Ground pin.
41	DIF6	OUT	Differential true clock output
42	DIF6#	OUT	Differential Complementary clock output
43	vOE6#	IN	Active low input for enabling DIF pair 6. This pin has an internal pull-down. 1 =disable outputs, 0 = enable outputs
44	DIF7	OUT	Differential true clock output
45	DIF7#	OUT	Differential Complementary clock output
46	vOE7#	IN	Active low input for enabling DIF pair 7. This pin has an internal pull-down. 1 =disable outputs, 0 = enable outputs
47	VDDIO	PWR	Power supply for differential outputs
48	^CKPWRGD_PD#	IN	Input notifies device to sample latched inputs and start up on first high assertion. Low enters Power Down Mode, subsequent high assertions exit Power Down Mode. This pin has internal pull-up resistor.

RENESAS

Test Loads



Alternate Terminations



Driving LVDS inputs

	, ,	Value			
	Receiver has	Receiver does not			
Component	termination	have termination	Note		
R7a, R7b	10K ohm	140 ohm			
R8a, R8b	5.6K ohm	75 ohm			
Cc	0.1 uF	0.1 uF			
Vcm	1.2 volts	1.2 volts			

Absolute Maximum Ratings

Stresses above the ratings listed below can cause permanent damage to the 9FGV0831. These ratings, which are standard values for IDT commercially rated parts, are stress ratings only. Functional operation of the device at these or any other conditions above those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods can affect product reliability. Electrical parameters are guaranteed only over the recommended operating temperature range.

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	МАХ	UNITS	NOTES
Supply Voltage	VDDxx	Applies to all VDD pins	-0.5		2	V	1,2
Input Voltage	V _{IN}		-0.5		V_{DD} +0.5V	V	1,3
Input High Voltage, SMBus	VIHSMB	SMBus clock and data pins			3.3V	V	1
Storage Temperature	Ts		-65		150	°C	1
Junction Temperature	Tj				125	°C	1
Input ESD protection	ESD prot	Human Body Model	2000			V	1

¹Guaranteed by design and characterization, not 100% tested in production.

² Operation under these conditions is neither implied nor guaranteed.

³ Not to exceed 2.5V.

Electrical Characteristics – Current Consumption

TA = T_{AMB}; Supply Voltages per normal operation conditions, See Test Loads for Loading Conditions

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
	I _{DDAOP}	VDDA, All outputs active @100MHz		6	9	mA	
Operating Supply Current	I _{DDOP}	All VDD, except VDDA and VDDIO, All outputs active @100MHz		9	14	mA	
	IDDIOOP	VDDIO, All outputs active @100MHz		27	35	mA	
Wake-on-LAN Current	I _{DDAPD}	VDDA, DIF outputs off, REF output running		0.4	1	mA	2
(CKPWRGD_PD# = '0' Byte 3, bit 5 = '1')	I _{DDPD}	All VDD, except VDDA and VDDIO, DIF outputs off, REF output running		4.4	7	mA	2
byte 3, bit 5 = 1)	IDDIOPD	VDDIO, DIF outputs off, REF output running		0.04	0.1	mA	2
Powerdown Current (CKPWRGD_PD# = '0' Byte 3, bit 5 = '0')	IDDAPD	VDDA, all outputs off		0.4	1	mA	
	I _{DDPD}	All VDD, except VDDA and VDDIO, all outputs off		0.4	1	mA	
	IDDIOPD	VDDIO, all outputs off		0.0003	0.1	mA	

¹ Guaranteed by design and characterization, not 100% tested in production.

² This is the current required to have the REF output running in Wake-on-LAN mode (Byte 3, bit 5 = 1)

Electrical Characteristics – DIF Output Duty Cycle, Jitter, and Skew Characteristics

TA = T_{AMB}; Supply Voltages per normal operation conditions, See Test Loads for Loading Conditions

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
Duty Cycle	t _{DC}	Measured differentially, PLL Mode	45	50	55	%	1,2
Skew, Output to Output	t _{sk3}	Averaging on, $V_T = 50\%$		32	60	ps	1
Jitter, Cycle to cycle	t _{jcyc-cyc}			16	50	ps	1,2

¹Guaranteed by design and characterization, not 100% tested in production.

² Measured from differential waveform

Electrical Characteristics – Input/Supply/Common Parameters - Normal Operating Conditions

TA = T_{AMB;} Supply Voltages per normal operation conditions, See Test Loads for Loading Conditions

$TA = T_{AMB}$; Supply Voltages	per normai c	peration conditions, See Test Loads for Loading Con	aitions				
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	МАХ	UNITS	NOTES
Supply Voltage	VDDxx	Supply voltage for core, analog and single-ended LVCMOS outputs	1.425	1.5	1.575	v	
Output Supply Voltage	VDDIO	Supply voltage for differential Low Power Outputs	0.9975	1.05-1.5	1.575	V	
Ambient Operating	T _{AMB}	Comercial range	0	25	70	°C	
Temperature	AMB	Industrial range	-40	25	85	°C	
Input High Voltage	V _{IH}	Single-ended inputs, except SMBus	$0.75 V_{DD}$		$V_{DD} + 0.3$	V	
Input Mid Voltage	V _{IM}	Single-ended tri-level inputs ('_tri' suffix)	0.4 V _{DD}	$0.5 V_{DD}$	0.6 V _{DD}	V	
Input Low Voltage	V _{IL}	Single-ended inputs, except SMBus	-0.3		$0.25 V_{DD}$	V	
Output High Voltage	VIH	Single-ended outputs, except SMBus. I _{OH} = -2mA	V _{DD} -0.45			V	
Output Low Voltage	V _{IL}	Single-ended outputs, except SMBus. I _{OL} = -2mA			0.45	V	
	I _{IN}	Single-ended inputs, $V_{IN} = GND$, $V_{IN} = VDD$	-5		5	uA	
Input Current	I _{INP}	Single-ended inputs $V_{IN} = 0 V$; Inputs with internal pull-up resistors $V_{IN} = VDD$; Inputs with internal pull-down resistors	-200		200	uA	
Input Frequency	F _{in}	XTAL, or X1 input	23	25	27	MHz	
Pin Inductance	L _{pin}	· · · ·			7	nH	1
0	C _{IN}	Logic Inputs, except DIF_IN	1.5		5	pF	1
Capacitance	C _{OUT}	Output pin capacitance			6	pF	1
Clk Stabilization	T _{STAB}	From V _{DD} Power-Up and after input clock stabilization or de-assertion of PD# to 1st clock			1.8	ms	1,2
SS Modulation Frequency	f _{MOD}	Triangular Modulation	30	31.6	33	kHz	1
OE# Latency	t _{LATOE#}	DIF start after OE# assertion DIF stop after OE# deassertion	1		3	clocks	1,3
Tdrive_PD#	t _{DRVPD}	DIF output enable after PD# de-assertion			300	us	1,3
Tfall	t _F	Fall time of single-ended control inputs			5	ns	2
Trise	t _R	Rise time of single-ended control inputs			5	ns	2
SMBus Input Low Voltage	VILSMB				0.6	V	
SMBus Input High Voltage	VIHSMB	$V_{DDSMB} = 3.3V$, see note 4 for $V_{DDSMB} < 3.3V$	2.1		3.3	V	4
SMBus Output Low Voltage	V _{OLSMB}	@ I _{PULLUP}			0.4	V	
SMBus Sink Current	I _{PULLUP}	@ V _{OL}	4			mA	
Nominal Bus Voltage	V _{DDSMB}		1.425		3.3	V	
SCLK/SDATA Rise Time	t _{RSMB}	(Max VIL - 0.15) to (Min VIH + 0.15)			1000	ns	1
SCLK/SDATA Fall Time	t _{FSMB}	(Min VIH + 0.15) to (Max VIL - 0.15)			300	ns	1
SMBus Operating Frequency	f _{MAXSMB}	Maximum SMBus operating frequency			400	kHz	1

¹ Guaranteed by design and characterization, not 100% tested in production.

² Control input must be monotonic from 20% to 80% of input swing.

 3 Time from deassertion until outputs are >200 mV

 4 For V_{DDSMB} < 3.3V, V_{IHSMB} >= 0.8xV_{DDSMB}

Electrical Characteristics – DIF Low-Power HCSL Outputs

TA = T_{AMB}: Supply Voltages per normal operation conditions, See Test Loads for Loading Conditions

AIMD, - FFF J J J J							
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
Slew rate	Trf	Scope averaging on fast setting	1.2	2.4	3.6	V/ns	1,2,3
Siew rate	111	Scope averaging on slow setting	0.8	1.7	2.5	V/ns	1,2,3
Slew rate matching	∆Trf	Slew rate matching, Scope averaging on		9	20	%	1,2,4
Voltage High	V _{HIGH}	Statistical measurement on single-ended signal using oscilloscope math function. (Scope	600	750	850	mV	7
Voltage Low	V _{LOW}	averaging on)	-150	26	150		7
Max Voltage	Vmax	Measurement on single ended signal using		763	1150	mV	7
Min Voltage	Vmin	absolute value. (Scope averaging off)	-300	22		IIIV	7
Vswing	Vswing	Scope averaging off	300	1448		mV	1,2,7
Crossing Voltage (abs)	Vcross_abs	Scope averaging off	250	390	550	mV	1,5,7
Crossing Voltage (var)	∆-Vcross	Scope averaging off		11	140	mV	1,6,7

¹Guaranteed by design and characterization, not 100% tested in production.

² Measured from differential waveform

³ Slew rate is measured through the Vswing voltage range centered around differential 0V. This results in a +/-150mV window around differential 0V.

⁴ Matching applies to rising edge rate for Clock and falling edge rate for Clock#. It is measured using a +/-75mV window centered on the average cross point where Clock rising meets Clock# falling. The median cross point is used to calculate the voltage thresholds the oscilloscope is to use for the edge rate calculations.

⁵ Vcross is defined as voltage where Clock = Clock# measured on a component test board and only applies to the differential rising edge (i.e. Clock rising and Clock# falling).

⁶ The total variation of all Vcross measurements in any particular system. Note that this is a subset of Vcross_min/max (Vcross absolute) allowed. The intent is to limit Vcross induced modulation by setting Δ -Vcross to be smaller than Vcross absolute.

⁷ At default SMBus amplitude settings.

Electrical Characteristics – DIF Output Phase Jitter Parameters

 $TA = T_{AMB}$; Supply Voltages per normal operation conditions, See Test Loads for Loading Conditions

PARAMETER	SYMBOL	CONDITIONS		TYP	MAX	IND. LIMIT	UNITS	Notes
	t _{jphPCleG1}	PCIe Gen 1		27.7	40	86	ps (p-p)	1,2,3,5
	t _{jph} PCleG2	PCIe Gen 2 Lo Band 10kHz < f < 1.5MHz		1.0	1.3	3	ps (rms)	1,2,3,5
Phase Jitter, PLL Mode		PCIe Gen 2 High Band 1.5MHz < f < Nyquist (50MHz)		1.9	2.2	3.1	ps (rms)	1,2,3,5
Thase officer, T LL Mode	t _{jphPCleG3}	PCIe Gen 3 Common Clock Architecture (PLL BW of 2-4 or 2-5MHz, CDR = 10MHz)		0.4	0.6	1	ps (rms)	1,2,3,5
t _{jph} PCleG3SRn S		PCIe Gen 3 Separate Reference No Spread (SRnS) (PLL BW of 2-4 or 2-5MHz, CDR = 10MHz)		0.4	0.6	0.7	ps (rms)	1,2,3,5

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² See http://www.pcisig.com for complete specs

³ Sample size of at least 100K cycles. This figures extrapolates to 108ps pk-pk @ 1M cycles for a BER of 1-12.

⁴ Calculated from Intel-supplied Clock Jitter Tool

⁵ Applies to all differential outputs

Electrical Characteristics – REF

TA = T_{AMB;} Supply Voltages per normal operation conditions, See Test Loads for Loading Conditions

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	Notes
Long Accuracy	ppm	see Tperiod min-max values		0		ppm	1,2
Clock period	T _{period}	25 MHz output		40		ns	2
Rise/Fall Slew Rate	t _{rf1}	Byte 3 = 1F, 20% to 80% of VDDREF	0.3	0.7	1.1	V/ns	1
Rise/Fall Slew Rate	t _{rf1}	Byte 3 = 5F, 20% to 80% of VDDREF	0.5	1.0	1.6	V/ns	1,3
Rise/Fall Slew Rate	t _{rf1}	Byte 3 = 9F, 20% to 80% of VDDREF	0.77	1.3	1.9	V/ns	1
Rise/Fall Slew Rate	t _{rf1}	Byte 3 = DF, 20% to 80% of VDDREF	0.84	1.4	2.0	V/ns	1
Duty Cycle	d _{t1X}	$V_T = VDD/2 V$	45	47.1	55	%	1,4
Duty Cycle Distortion	d _{tcd}	$V_T = VDD/2 V$, when driven by XIN/CLKIN_25 pin	0	2.00	4	%	1,5
Jitter, cycle to cycle	t _{jcyc-cyc}	$V_T = VDD/2 V$		51.2	250	ps	1,4
Noise floor	t _{jdBc1k}	1kHz offset		-126	-105	dBc	1,4
Noise floor	t _{jdBc10k}	10kHz offset to Nyquist		-139	-110	dBc	1,4
Jitter, phase	t _{jphREF}	12kHz to 5MHz		1.11	3	ps (rms)	1,4

¹Guaranteed by design and characterization, not 100% tested in production.

² All Long Term Accuracy and Clock Period specifications are guaranteed assuming that REF is trimmed to 25.00 MHz

³ Default SMBus Value

⁴ When driven by a crystal.

⁵ X2 should be floating.

Clock Periods - Differential Outputs with Spread Spectrum Disabled

			Measurement Window							
	Center	1 Clock	1us	0.1s	0.1s	0.1s	1us	1 Clock		
SSC OFF	Freq. MHz	-c2c jitter AbsPer Min	-SSC Short-Term Average Min	- ppm Long-Term Average Min	0 ppm Period Nominal	+ ppm Long-Term Average Max	+SSC Short-Term Average Max	+c2c jitter AbsPer Max	Units	Notes
DIF	100.00	9.94900		9.99900	10.00000	10.00100		10.05100	ns	1,2

Clock Periods - Differential Outputs with Spread Spectrum Enabled

			Measurement Window							
Cont	Center	1 Clock	1us	0.1s	0.1s	0.1s	1us	1 Clock		
SSC ON	Freq. MHz	-c2c jitter AbsPer Min	-SSC Short-Term Average Min	- ppm Long-Term Average Min	0 ppm Period Nominal	+ ppm Long-Term Average Max	+SSC Short-Term Average Max	+c2c jitter AbsPer Max	Units	Notes
DIF	99.75	9.94906	9.99906	10.02406	10.02506	10.02607	10.05107	10.10107	ns	1,2

¹Guaranteed by design and characterization, not 100% tested in production.

² All Long Term Accuracy and Clock Period specifications are guaranteed assuming that REF is trimmed to 25.00 MHz

General SMBUS Serial Interface Information

How to Write

- Controller (host) sends a start bit
- Controller (host) sends the write address
- IDT clock will acknowledge
- Controller (host) sends the beginning byte location = N
- IDT clock will acknowledge
- Controller (host) sends the byte count = X
- IDT clock will acknowledge
- Controller (host) starts sending Byte N through Byte N+X-1
- IDT clock will acknowledge each byte one at a time
- Controller (host) sends a Stop bit

	Index BI	ock V	Irite Operation
Controll	er (Host)		IDT (Slave/Receiver)
Т	starT bit		
Slave A	Address		
WR	WRite		
			ACK
Beginning	g Byte = N		
			ACK
Data Byte	Count = X		
			ACK
Beginnin	g Byte N		
			ACK
0		×	
0		X Byte	0
0		Ø	0
			0
Byte N	+ X - 1		
			ACK
Р	stoP bit		

Note: SMBus address is Latched on SADR pin.

How to Read

- Controller (host) will send a start bit
- Controller (host) sends the write address
- IDT clock will acknowledge
- Controller (host) sends the beginning byte location = N
- IDT clock will acknowledge
- Controller (host) will send a separate start bit
- Controller (host) sends the read address
- IDT clock will acknowledge
- IDT clock will send the data byte count = X
- IDT clock sends Byte N+X-1
- IDT clock sends Byte 0 through Byte X (if X_(H) was written to Byte 8)
- Controller (host) will need to acknowledge each byte
- Controller (host) will send a not acknowledge bit
- Controller (host) will send a stop bit

	Index Block F	Read O	peration
Co	ntroller (Host)		IDT (Slave/Receiver)
Т	starT bit		
S	lave Address		
WR	WRite		
		_	ACK
Beg	inning Byte = N	_	
			ACK
RT	Repeat starT		
S	lave Address		
RD	ReaD		
		_	ACK
		_	
		_	Data Byte Count=X
	ACK		
		-	Beginning Byte N
	ACK		
		te te	0
	0	X Byte	0
	0	×	0
	0		
	1		Byte N + X - 1
Ν	Not acknowledge		
Р	stoP bit		

SMBus Table: Output Enable Register ¹

Byte 0	Name	Control Function	Туре	0	1	Default
Bit 7	DIF OE7	Output Enable	RW	Low/Low	Enabled	1
Bit 6	DIF OE6	Output Enable	RW	Low/Low	Enabled	1
Bit 5	DIF OE5	Output Enable	RW	Low/Low	Enabled	1
Bit 4	DIF OE4	Output Enable	RW	Low/Low	Enabled	1
Bit 3	DIF OE3	Output Enable	RW	Low/Low	Enabled	1
Bit 2	DIF OE2	Output Enable	RW	Low/Low	Enabled	1
Bit 1	DIF OE1	Output Enable	RW	Low/Low	Enabled	1
Bit 0	DIF OE0	Output Enable	RW	Low/Low	Enabled	1

1. A low on these bits will overide the OE# pin and force the differential output Low/Low

SMBus Table: SS Readback and Control Register

Byte 1	Name	Control Function	Туре	0	1	Default
Bit 7	SSENRB1	SS Enable Readback Bit1	R	00' for SS_EN_tri =	0, '01' for SS_EN_tri	Latch
Bit 6	SSENRB1	SS Enable Readback Bit0	R	= 'M', '11 for S	S_EN_tri = '1'	Latch
Bit 5	SSEN_SWCNTRL	Enable SW control of SS	RW	Values in B1[7:6] control SS amount	Values in B1[4:3] control SS amount.	0
Bit 4	SSENSW1	SS Enable Software Ctl Bit1	RW ¹	00' = SS Off, '0'	1' = -0.25% SS,	0
Bit 3	SSENSW0	SS Enable Software Ctl Bit0	RW ¹	'10' = Reserved	, '11'= -0.5% SS	0
Bit 2		Reserved				1
Bit 1	AMPLITUDE 1	Controls Output Amplitude	RW	00 = 0.55V	01 = 0.65V	1
Bit 0	AMPLITUDE 0		RW	10= 0.7V	11 = 0.8V	0

1. B1[5] must be set to a 1 for these bits to have any effect on the part.

SMBus Table: DIF Slew Rate Control Register

Byte 2	Name	Control Function	Туре	0	1	Default
Bit 7	SLEWRATESEL DIF7	Adjust Slew Rate of DIF7	RW	Slow Setting	Fast Setting	1
Bit 6	SLEWRATESEL DIF6	Adjust Slew Rate of DIF6	RW	Slow Setting	Fast Setting	1
Bit 5	SLEWRATESEL DIF5	Adjust Slew Rate of DIF5	RW	Slow Setting	Fast Setting	1
Bit 4	SLEWRATESEL DIF4	Adjust Slew Rate of DIF4	RW	Slow Setting	Fast Setting	1
Bit 3	SLEWRATESEL DIF3	Adjust Slew Rate of DIF3	RW	Slow Setting	Fast Setting	1
Bit 2	SLEWRATESEL DIF2	Adjust Slew Rate of DIF2	RW	Slow Setting	Fast Setting	1
Bit 1	SLEWRATESEL DIF1	Adjust Slew Rate of DIF1	RW	Slow Setting	Fast Setting	1
Bit 0	SLEWRATESEL DIF0	Adjust Slew Rate of DIF0	RW	Slow Setting	Fast Setting	1

SMBus Table: Nominal Vhigh Amplitude Control/ REF Control Register

Byte 3	Name	Control Function	Туре	0	1	Default
Bit 7	REF	Slew Rate Control	RW	00 = Slowest	01 = Slow	0
Bit 6	INE!			10 = Fast	11 = Faster	1
Bit 5	REF Power Down Function	Wake-on-Lan Enable for REF	RW	REF does not run in Power Down	REF runs in Power Down	0
Bit 4	REF OE	REF Output Enable	RW	Low	Enabled	1
Bit 3		Reserved				1
Bit 2		Reserved				1
Bit 1	Reserved					
Bit 0		Reserved				1

Byte 4 is Reserved

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SMBus Table: Revision and Vendor ID Register

Byte 5	Name	Control Function	Туре	0	1	Default
Bit 7	RID3		R		0	
Bit 6	RID2	Revision ID	R	A rove	0	
Bit 5	RID1	Revision ID	R	A rev = 0000		0
Bit 4	RID0		R		0	
Bit 3	VID3		R			0
Bit 2	VID2	VENDOR ID	R	0001 = IDT		0
Bit 1	VID1	VENDOR ID	R			0
Bit 0	VID0		R			1

SMBus Table: Device Type/Device ID

Byte 6	Name	Control Function	Туре	0	1	Default
Bit 7	Device Type1	Device Type	R	00 = FGx, 01 =	DBx ZDB/FOB,	0
Bit 6	Device Type0	Device Type	R	10 = DMx, 11= DBx FOB		0
Bit 5	Device ID5		R			0
Bit 4	Device ID4		R	001000 binary or 08 hex		0
Bit 3	Device ID3	Device ID	R			1
Bit 2	Device ID2	Device iD	R			0
Bit 1	Device ID1		R			0
Bit 0	Device ID0		R			0

SMBus Table: Byte Count Register

Byte 7	Name	Control Function	Туре	0	1	Default
Bit 7	Reserved					0
Bit 6	Reserved				0	
Bit 5	Reserved				0	
Bit 4	BC4		RW			0
Bit 3	BC3	1	RW	Writing to this regist	er will configure how	1
Bit 2	BC2	Byte Count Programming	RW	many bytes will be r	ead back, default is	0
Bit 1	BC1		RW	= 8 b	ytes.	0
Bit 0	BC0		RW			0

Recommended Crystal Characteristics (3225 package)

PARAMETER	VALUE	UNITS	NOTES
Frequency	25	MHz	1
Resonance Mode	Fundamental	-	1
Frequency Tolerance @ 25°C	±20	PPM Max	1
Frequency Stability, ref @ 25°C Over	±20	PPM Max	1
Operating Temperature Range		-	
Temperature Range (commerical)	0~70	°C	1
Temperature Range (industrial)	-40~85	°C	2
Equivalent Series Resistance (ESR)	50	Ω Max	1
Shunt Capacitance (C _O)	7	pF Max	1
Load Capacitance (CL)	8	pF Max	1
Drive Level	0.3	mW Max	1
Aging per year	±5	PPM Max	1

Notes:

1. FOX 603-25-150.

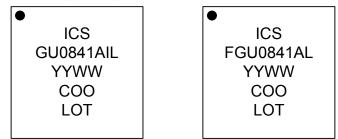
2. For I-temp, FOX 603-25-261.

Thermal Characteristics

PARAMETER	SYMBOL	CONDITIONS	PKG	TYP.	UNITS	NOTES
	θ _{JC}	Junction to Case	NDG48	33	°C/W	1
	θ_{Jb}	Junction to Base		2.1	°C/W	1
Thermal Resistance	θ_{JA0}	Junction to Air, still air		37	°C/W	1
mermai resistance	θ_{JA1}	Junction to Air, 1 m/s air flow		30	°C/W	1
	θ_{JA3}	Junction to Air, 3 m/s air flow		27	°C/W	1
	θ_{JA5}	Junction to Air, 5 m/s air flow		26	°C/W	1

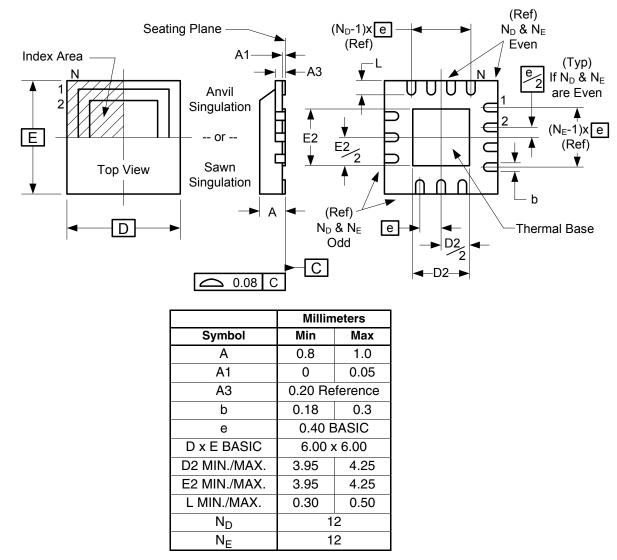
¹ePad soldered to board

Marking Diagrams



Notes:

- 1. Line 2 is the truncated part number.
- 2. 'L' denotes RoHS compliant package.
- 3. 'I' denotes industrial temperature grade.
- 4. 'YYWW' is the last two digits of the year and week that the part was assembled.
- 5. 'COO' denotes country of origin.
- 6. 'LOT' is the lot number.



Package Outline and Package Dimensions (NDG48, 48-pin VFQFPN)

Ordering Information

Part / Order Number	Shipping Packaging	Package	Temperature
9FGU0841AKLF	Trays	48-pin VFQFPN	0 to +70° C
9FGU0841AKLFT	Tape and Reel	48-pin VFQFPN	0 to +70° C
9FGU0841AKILF	Trays	48-pin VFQFPN	-40 to +85° C
9FGU0841AKLIFT	Tape and Reel	48-pin VFQFPN	-40 to +85° C

"LF" to the suffix are the Pb-Free configuration and are RoHS compliant.

"A" is the device revision designator (will not correlate to with the datasheet revision).

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Revision History

Rev.	Issue Date	Intiator	Description	Page #
A	9/24/2014	RDW	 Updated electrical tables with latest and last versions for release Updated SMBus nomenclature for consistency with the family Removed references to Suspend Mode – and the Suspend Rail. This is replaced by Power Down with Wake-on-LAN modes in the current consumption table. Updated GenDes tab for front page consistency. Move to final. 	Various
В	8/14/2015	RDW	Corrected typo in ordering information	14
С	10/18/2016	RDW	Removed IDT crystal part number	



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